CLAIMS

What is claimed is:

- 1. In combination, a semiconductor substrate singulation saw and a chuck for holding a substrate comprising:
- a saw having at least one blade supported above a table and oriented to cut mutually parallel paths in the surface of a semiconductor substrate positioned on said table; and a chuck having at least one cutting pedestal located thereon mounted on said table, said chuck for holding said substrate during the cutting thereof by said saw.
- 2. The combination of claim 1, wherein said chuck further comprises: a chuck table; and a plurality of cutting pedestals, each cutting pedestal being mounted on said chuck table.
- 3. The combination of claim 2, wherein said chuck further comprises: at least one clamp pedestal; and at least one substrate clamp removable attached to a portion of the at least one clamp pedestal.
- 4. The combination of claim 3, wherein said chuck further comprises: at least one alignment apparatus having a portion attached to the chuck table.
- 5. The combination of claim 4, wherein said alignment apparatus comprises: at least one alignment pin having a portion for engaging a portion of a substrate.
- 6. The combination of claim 4, wherein said alignment apparatus comprises: an aperture in the chuck table for receiving said substrate therein.
- 7. The combination of claim 4, wherein said alignment apparatus comprises: a pair of alignment pins, each alignment pin having a portion thereof attached to the chuck table and a portion for engaging a portion of said substrate.

- 8. The combination of claim 1, the saw further comprising: at least two blades for sawing said substrate.
- 9. The combination of claim 8, wherein at least one of said at least two blades is laterally translatable relative to another of said at least two blades.
- 10. The combination of claim 9, wherein at least one of said at least two blades is raisable relative to another of said at least two blades.
- 11. The combination of claim 8, wherein said table is translatable in at least one direction relative to said at least two blades.
- 12. The combination of claim 8, wherein said at least two blades are translatable in at least one direction relative to said table.
- 13. In combination, a semiconductor substrate singulation saw and a table for mounting a substrate comprising:
 a saw having at least two blades supported above a table and oriented to cut mutually parallel paths in the surface of a semiconductor substrate positioned on said table; and
 a chuck having at least one cutting pedestal located thereon mounted on said table, said chuck for holding said substrate during the cutting thereof by said saw.
- 14. The combination of claim 13, wherein said chuck further comprises: a chuck table; and a plurality of cutting pedestals, each cutting pedestal being mounted on said chuck table.
- 15. The combination of claim 14, wherein said chuck further comprises: at least one clamp pedestal; and at least one substrate clamp removable attached to a portion of the at least one clamp pedestal.

- 16. The combination of claim 15, wherein said chuck further comprises: at least one alignment apparatus having a portion attached to the chuck table.
- 17. The combination of claim 16, wherein said alignment apparatus comprises: at least one alignment pin having a portion for engaging a portion of a substrate.
- 18. The combination of claim 16, wherein said alignment apparatus comprises: an aperture in the chuck table for receiving said substrate therein.
- 19. The combination of claim 16, wherein said alignment apparatus comprises: a pair of alignment pins, each alignment pin having a portion thereof attached to the chuck table and a portion for engaging a portion of said substrate.
- 20. The combination of claim 13, the saw further comprising: at least two blades for sawing said substrate.
- 21. The combination of claim 20, wherein at least one of said at least two blades is laterally translatable relative to another of said at least two blades.
- 22. The combination of claim 21, wherein at least one of said at least two blades is raisable relative to another of said at least two blades.
- 23. The combination of claim 20, wherein said table is translatable in at least one direction relative to said at least two blades.
- 24. The combination of claim 20, wherein said at least two blades are translatable in at least one direction relative to said table.

- 25. A chuck used for semiconductor substrate singulation for holding a substrate to be singulated in a saw having a table comprising:
 a chuck having at least one cutting pedestal located thereon mounted on said table, said chuck for holding said substrate during the cutting thereof by said saw.
- 26. The chuck of claim 25, wherein said chuck further comprises: a plurality of cutting pedestals, each cutting pedestal being mounted on said chuck table.
- 27. The chuck of claim 26, wherein said chuck further comprises: at least one clamp pedestal; and at least one substrate clamp removable attached to a portion of the at least one clamp pedestal.
- 28. The chuck of claim 27, wherein said chuck further comprises: at least one alignment apparatus having a portion attached to the chuck table.
- 29. The chuck of claim 28, wherein said alignment apparatus comprises: at least one alignment pin having a portion for engaging a portion of a substrate.
- 30. The chuck of claim 28, wherein said alignment apparatus comprises: an aperture in the chuck table for receiving said substrate therein.
- 31. The chuck of claim 28, wherein said alignment apparatus comprises:
 a pair of alignment pins, each alignment pin having a portion thereof attached to the chuck table and a portion for engaging a portion of said substrate.
- 32. A method for singulating a plurality of semiconductor devices located on a substrate comprising:
 providing a saw having at least one blade and a table;

providing a chuck having at least one cutting pedestal located thereon mounted on the table,

said chuck for holding said substrate during the cutting thereof by said saw; providing a substrate having a plurality of semiconductor devices located thereon; placing said substrate in the chuck; aligning the substrate in the chuck; supporting at least one semiconductor device on a portion of the chuck; and sawing at least one semiconductor device from said substrate.

- 33. The method of claim 32, further comprising: applying a vacuum to a portion of the at least one semiconductor device supported on a portion of the at least one cutting pedestal of the chuck.
- 34. The method of claim 32, further comprising: sawing a plurality of semiconductor devices from said substrate at substantially the same time.
- 35. The method of claim 32, further comprising: supporting a plurality of semiconductor devices on a portion of the chuck.
- 36. The method of claim 34, further comprising: supporting a plurality of semiconductor devices on portions of the chuck during the sawing thereof from said substrate.
- 37. A method for singulating a plurality of semiconductor devices located on a substrate comprising:

providing a saw having at least two blades and a table;

providing a chuck having at least two cutting pedestals located thereon mounted on the table,

said chuck for holding said substrate during the cutting thereof by said saw; providing a substrate having a plurality of semiconductor devices located thereon; placing said substrate in the chuck;

aligning the substrate in the chuck; supporting at least two semiconductor devices on portions of the chuck; and sawing at least two semiconductor devices from said substrate.

- 38. The method of claim 37, further comprising: applying a vacuum to a portion of the at least two semiconductor devices supported on portions of the at least one cutting pedestal of the chuck.
- 39. The method of claim 37, further comprising: sawing more than two semiconductor devices from said substrate at substantially the same time.
- 40. The method of claim 37, further comprising: supporting more than two semiconductor devices on a portion of the chuck.
- 41. The method of claim 37, further comprising: supporting a plurality of more than two semiconductor devices on portions of the chuck during the sawing thereof from said substrate.
- 42. An apparatus for singulation of a semiconductor substrate comprising:

 a saw having at least one blade supported above a table and oriented to cut mutually parallel paths in the surface of a semiconductor substrate positioned on said table; and a chuck having at least one cutting pedestal located thereon mounted on said table, said chuck for holding said substrate during the cutting thereof by said saw.
- 43. The apparatus of claim 42, wherein said chuck further comprises:
 a chuck table; and
 a plurality of cutting pedestals, each cutting pedestal being mounted on said chuck table.

- 44. The apparatus of claim 42, wherein said chuck further comprises: at least one clamp pedestal; and at least one substrate clamp removable attached to a portion of the at least one clamp pedestal.
- 45. The apparatus of claim 44, wherein said chuck further comprises: at least one alignment apparatus having a portion attached to the chuck table.
- 46. The apparatus of claim 45, wherein said alignment apparatus comprises: at least one alignment pin having a portion for engaging a portion of a substrate.
- 47. The apparatus of claim 45, wherein said alignment apparatus comprises: an aperture in the chuck table for receiving said substrate therein.
- 48. The apparatus of claim 45, wherein said alignment apparatus comprises: a pair of alignment pins, each alignment pin having a portion thereof attached to the chuck table and a portion for engaging a portion of said substrate.
- 49. The apparatus of claim 42, the saw further comprising: at least two blades for sawing said substrate.
- 50. The apparatus of claim 49, wherein at least one of said at least two blades is laterally translatable relative to another of said at least two blades.
- 51. The apparatus of claim 50, wherein at least one of said at least two blades is raisable relative to another of said at least two blades.
- 52. The apparatus of claim 49, wherein said table is translatable in at least one direction relative to said at least two blades.

- 53. The apparatus of claim 49, wherein said at least two blades are translatable in at least one direction relative to said table.
- 54. An apparatus for the singulation of a substrate comprising:

 a saw having at least two blades supported above a table and oriented to cut mutually parallel paths in the surface of a semiconductor substrate positioned on said table; and a chuck having at least one cutting pedestal located thereon mounted on said table, said chuck for holding said substrate during the cutting thereof by said saw.
- 55. The apparatus of claim 54, wherein said chuck further comprises: a chuck table; and a plurality of cutting pedestals, each cutting pedestal being mounted on said chuck table.
- 56. The apparatus of claim 55, wherein said chuck further comprises: at least one clamp pedestal; and at least one substrate clamp removable attached to a portion of the at least one clamp pedestal.
- 57. The apparatus of claim 56, wherein said chuck further comprises: at least one alignment apparatus having a portion attached to the chuck table.
- 58. The apparatus of claim 57, wherein said alignment apparatus comprises: at least one alignment pin having a portion for engaging a portion of a substrate.
- 59. The apparatus of claim 57, wherein said alignment apparatus comprises: an aperture in the chuck table for receiving said substrate therein.
- 60. The apparatus of claim 57, wherein said alignment apparatus comprises: a pair of alignment pins, each alignment pin having a portion thereof attached to the chuck table and a portion for engaging a portion of said substrate.

- 61. The apparatus of claim 54, the saw further comprising: at least two blades for sawing said substrate.
- 62. The apparatus of claim 61, wherein at least one of said at least two blades is laterally translatable relative to another of said at least two blades.
- 63. The apparatus of claim 62, wherein at least one of said at least two blades is raisable relative to another of said at least two blades.
- 64. The apparatus of claim 61, wherein said table is translatable in at least one direction relative to said at least two blades.
- 65. The apparatus of claim 61, wherein said at least two blades are translatable in at least one direction relative to said table.
- 66. A method for singulating a substrate having a plurality of semiconductor devices located thereon using a saw having at least one blade and a table having a chuck having at least one cutting pedestal, said chuck for holding said substrate, comprising: placing said substrate in the chuck; aligning the substrate in the chuck; supporting at least one semiconductor device on a portion of the chuck; and sawing at least one semiconductor device from said substrate.
- 67. The method of claim 66, further comprising: applying a vacuum to a portion of the at least one semiconductor device supported on a portion of the at least one cutting pedestal of the chuck.
- 68. The method of claim 66, further comprising: sawing a plurality of semiconductor devices from said substrate at substantially the same time.

- 69. The method of claim 66, further comprising: supporting a plurality of semiconductor devices on a portion of the chuck.
- 70. The method of claim 68, further comprising: supporting a plurality of semiconductor devices on portions of the chuck during the sawing thereof from said substrate.
- 71. A method for singulating a substrate having plurality of semiconductor devices using a saw having at least two blades and a table having a chuck having at least two cutting pedestals, said chuck for holding said substrate, comprising: placing said substrate in the chuck; aligning the substrate in the chuck; supporting at least two semiconductor devices on portions of the chuck; and sawing at least two semiconductor devices from said substrate.
- 72. The method of claim 71, further comprising: applying a vacuum to a portion of the at least two semiconductor devices supported on portions of the at least one cutting pedestal of the chuck.
- 73. The method of claim 71, further comprising: sawing more than two semiconductor devices from said substrate at substantially the same time.
- 74. The method of claim 71, further comprising: supporting more than two semiconductor devices on a portion of the chuck.
- 75. The method of claim 71, further comprising: supporting a plurality of more than two semiconductor devices on portions of the chuck during the sawing thereof from said substrate.